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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application No.:

Not yet assigned

Applicants:

Eri TSUKADA, et al.

Filed Internationally:

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US National:

Herewith

Title:

METHOD FOR PRODUCING SILICON NITRIDE FILMS AND

SILICON OXYNITRIDE FILMS BY CHEMICAL VAPOR

DEPOSITION

TC/A.U:

Unknown

Examiner:

Unknown

Docket No.:

Serie 6497

Customer No.:

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PRELIMINARY AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Prior to an examination of the merits of the above-identified U.S. patent application under 37 C.F.R. § 1.115, please first amend the application as follows:

Amendments to the Claims begin on page 2 of this paper.

Remarks begin on page 4 of this paper.

An **Appendix** including the Abstract is attached following page 4 of this paper.